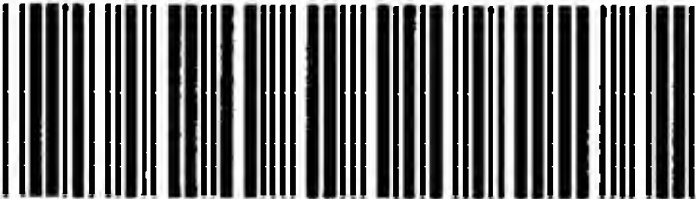


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,203	MAJEED ET AL.	
	Examiner	Art Unit	
	Susan Hanley	1651	

SEARCHED			
Class	Subclass	Date	Examiner
435	155,157	12/6/2005	FCP
updated		8/27/2006	SMH
updated		12/20/2006	SMH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
435	155,157	12/20/2006	SMH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor name in PALM; USPAT, USPGPUB,USOCR,EPO,JPO, DERWENT,CAPLUS,BIOSIS, see enclosed	12/6/2005	FCP
WEST: USPAT, EPAB, JPAB, DWPI, PGPUBS, see enclosed	8/27/2006	SMH
WEST: USPAT, EPAB, JPAB, DWPI, PGPUBS, see enclosed	12/20/2006	SMH
Interfernece Search, see attached	12/20/2006	SMH